

UNISONIC TECHNOLOGIES CO., LTD

4N60-E Power MOSFET

4A, 600V **N-CHANNEL POWER MOSFET**

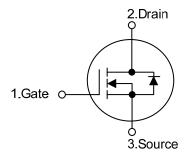
DESCRIPTION

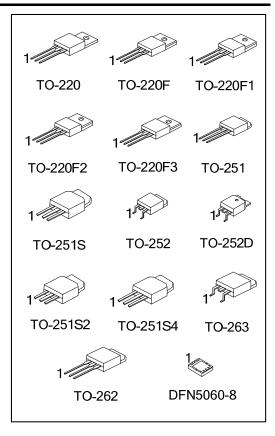
The UTC 4N60-E is a high voltage power MOSFET and is designed to have better characteristics, such as fast switching time, low gate charge, low on-state resistance and have a high rugged avalanche characteristics. This power MOSFET is usually used at high speed switching applications in power supplies, PWM motor controls, high efficient DC to DC converters and bridge circuits.

FEATURES

- * $R_{DS(ON)}$ < 2.5 Ω @ V_{GS} = 10 V, I_D = 2.2A
- * Fast Switching Capability
- * Avalanche Energy Specified
- * Improved dv/dt Capability, high Ruggedness

SYMBOL



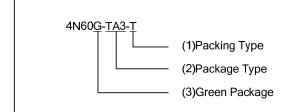


www.unisonic.com.tw 1 of 7 QW-R502-970.D

ORDERING INFORMATION

Ordering Number		Daakaga	Pin Assignment							Dooking	
Lead Free	Halogen Free	Package	1	2	3	4	5	6	7	8	Packing
4N60L-TA3-T	4N60G-TA3-T	TO-220	G	D	S	-	ı	-	-	-	Tube
4N60L-TF3-T	4N60G-TF3-T	TO-220F	G	D	S	-	ı	-	-	-	Tube
4N60L-TF1-T	4N60G-TF1-T	TO-220F1	G	D	S	-	ı	-	-	-	Tube
4N60L-TF2-T	4N60G-TF2-T	TO-220F2	G	D	S	-	ı	-	-	-	Tube
4N60L-TF3T-T	4N60G-TF3T-T	TO-220F3	G	D	S	-	ı	-	-	-	Tube
4N60L-TM3-T	4N60G-TM3-T	TO-251	G	D	S	-	ı	-	-	-	Tube
4N60L-TMS-T	4N60G-TMS-T	TO-251S	G	D	S	-	ı	-	-	-	Tube
4N60L-TMS2-T	4N60G-TMS2-T	TO-251S2	G	D	S	-	-	-	-	-	Tube
4N60L-TMS4-T	4N60G-TMS4-T	TO-251S4	G	D	S	-	ı	-	-	-	Tube
4N60L-TN3-R	4N60G-TN3-R	TO-252	G	D	S	-	ı	-	-	-	Tape Reel
4N60L-TND-R	4N60G-TND-R	TO-252D	G	D	S	ı	ı	-	-	-	Tape Reel
4N60L-T2Q-T	4N60G-T2Q-T	TO-262	G	D	S	-	ı	-	-	-	Tube
4N60L-TQ2-R	4N60G-TQ2-R	TO-263	G	D	S	-	-	-	-	-	Tape Reel
4N60L-TQ2-T	4N60G-TQ2-T	TO-263	G	D	S	-	•	-	-	-	Tube
4N60L-K08-5060-R	4N60G-K08-5060-R	DFN5060-8	S	S	S	G	D	D	D	D	Tape Reel

Note: Pin Assignment: G: Gate D: Drain S: Source



- (1) T: Tube, R: Tape Reel
- (2) TA3: TO-220, TF1: TO-220F1, TF2: TO-220F2, TF3: TO-220F, TF3T: TO-220F3, TM3: TO-251, TMS: TO-251S, TN3: TO-252, TND: TO-252D TMS2: TO-251S2, TMS4: TO-251S4, T2Q: TO-262, TQ2: TO-263, K08-3030: DFN5060-8
- (3) G: Halogen Free and Lead Free, L: Lead Free

■ MARKING

PACKAGE		MARKING				
TO-220 TO-220F TO-220F1 TO-220F2 TO-220F3 TO-251 TO-251S	TO-251S2 TO-251S4 TO-252 TO-252D TO-262 TO-263	UTC 4N60 □ Cit L: Lead Free G: Halogen Free Data Code 1				
DFN5060-8		UTC 4N60 □□□□□□□□ Lot Code Date Code				

■ ABSOLUTE MAXIMUM RATINGS (T_C = 25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT
Drain-Source Voltage		V_{DSS}	600	V
Gate-Source Voltage		V_{GSS}	±30	V
Avalanche Current (Note 2)		I_{AR}	4.4	Α
Desire Courses	Continuous	I_{D}	4.0	Α
Drain Current	Pulsed (Note 2)	I_{DM}	16	Α
Avalancha Energy	Single Pulsed (Note 3)	E _{AS}	200	mJ
Avalanche Energy	Repetitive (Note 2)	E_{AR}	10.6	mJ
Peak Diode Recovery	/ dv/dt (Note 4)	dv/dt	4.5	V/ns
	TO-220/TO-262/TO-263		106	
Power Dissipation	TO-220F/TO-220F1 TO-220F3		36	
	TO-220F2	Б	38	١٨,
	TO-251/TO-252/TO-252D TO-251S/TO-251S2 TO-251S4	P_D	50	W
	DFN5060-8		30	
Junction Temperature		TJ	+150	°C
Operating Temperature		T_OPR	-55 ~ +150	°C
Storage Temperature		T _{STG}	-55 ~ +150	°C

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

- 2. Repetitive Rating: Pulse width limited by maximum junction temperature
- 3. L = 30mH, I_{AS} = 3.65A, V_{DD} = 50V, R_G = 25 Ω , Starting T_J = 25°C
- 4. $I_{SD} \le 4.4A$, di/dt $\le 200A/\mu s$, $V_{DD} \le BV_{DSS}$, Starting $T_J = 25^{\circ}C$

■ THERMAL DATA

PARAMETER	PACKAGE	SYMBOL	RATINGS	UNIT
Junction to Ambient	TO-220/TO-262/TO-263 TO-220F/TO-220F1 TO-220F2/TO-220F3		62.5	
	TO-251/TO-252/TO-252D TO-251S/TO-251S2 TO-251S4	θЈА	110	°C/W
	DFN5060-8		75	
	TO-220/TO-262/TO-263		1.18	
Junction to Case	TO-220F/TO-220F1 TO-220F3		3.47	
	TO-220F2	Δ	3.28	°C/W
	TO-251/TO-252/TO-252D TO-251S/TO-251S2 TO-251S4	θ _{ЈС}	2.5	C/VV
	DFN5060-8		4.17	

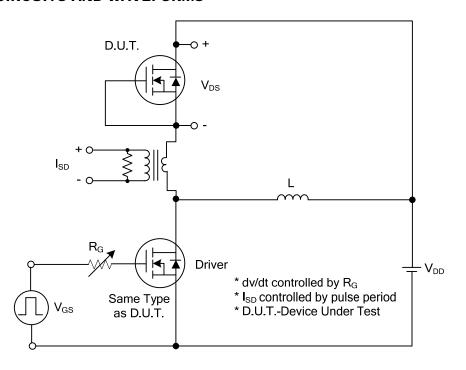
■ **ELECTRICAL CHARACTERISTICS** (T_C =25°C, unless otherwise specified)

PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT	
OFF CHARACTERISTICS								
Drain-Source Breakdown Voltage		BV _{DSS}	$V_{GS} = 0V, I_D = 250\mu A$	600			V	
Drain-Source Leakage Current		I _{DSS}	$V_{DS} = 600V, V_{GS} = 0V$			10	μΑ	
Gate-Source Leakage Current	Forward	I _{GSS}	$V_{GS} = 30V, V_{DS} = 0V$			100	nA	
Re	everse		$V_{GS} = -30V, V_{DS} = 0V$			-100	nA	
Breakdown Voltage Temperature Coe	efficient	$\triangle BV_{DSS}/\triangle T_{J}$	I _D =250μA,Referenced to 25°C		0.6		V/°C	
ON CHARACTERISTICS								
Gate Threshold Voltage		$V_{GS(TH)}$	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	2.0		4.0	V	
Static Drain-Source On-State Resista	ance	R _{DS(ON)}	$V_{GS} = 10 \text{ V}, I_D = 2.2 \text{A}$		2.3	2.5	Ω	
DYNAMIC CHARACTERISTICS								
Input Capacitance		C_{ISS}	$V_{DS} = 25V, V_{GS} = 0V,$		520	620	pF	
Output Capacitance		Coss	f = 1MHz		55	75	pF	
Reverse Transfer Capacitance		C_{RSS}	1 - 1101112		11	15	pF	
SWITCHING CHARACTERISTICS								
Total Gate Charge		Q_G	V _{DS} = 480V,I _D = 4.0A,		65		nC	
Gate-Source Charge		Q_GS	V _{GS} = 400 V,1 _D = 4.0A, V _{GS} = 10V (Note 1, 2)		6		nC	
Gate-Drain Charge		Q_GD	V _{GS} = 10V (Note 1, 2)		8		nC	
Turn-On Delay Time		$t_{D(ON)}$			60	130	ns	
Turn-On Rise Time		t_{R}	$V_{DD} = 300V, I_D = 4.0A,$		60	100	ns	
Turn-Off Delay Time		$t_{D(OFF)}$	$R_G = 25\Omega \text{ (Note 1, 2)}$		220	260	ns	
Turn-Off Fall Time		t _F			70	100	ns	
SOURCE- DRAIN DIODE RATINGS AND CHARACTERISTICS								
Maximum Continuous Drain-Source Diode		Is				4.4	Α	
Forward Current						4.4	A	
Maximum Pulsed Drain-Source Diode	е	Land				17.6	Α	
Forward Current		I _{SM}				17.0	Α	
Drain-Source Diode Forward Voltage	;	V_{SD}	$V_{GS} = 0V, I_{S} = 4.4A$			1.4	V	
Reverse Recovery Time		t _{rr}	$V_{GS} = 0 \text{ V}, I_S = 4.4\text{A},$		250		ns	
Reverse Recovery Charge		Q_{rr}	dI _F /dt = 100 A/μs (Note 1)		1.5		μC	

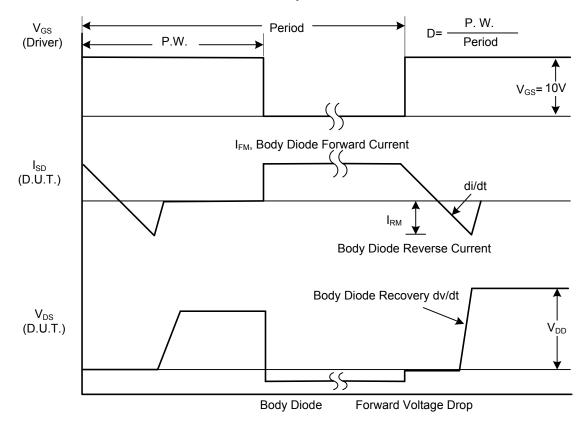
Notes: 1. Pulse Test: Pulse width≤300µs, Duty cycle≤2%

^{2.} Essentially independent of operating temperature

■ TEST CIRCUITS AND WAVEFORMS

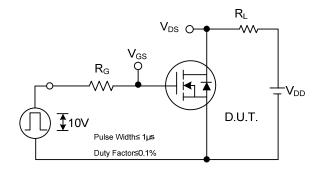


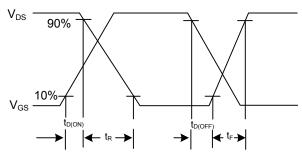
Peak Diode Recovery dv/dt Test Circuit



Peak Diode Recovery dv/dt Waveforms

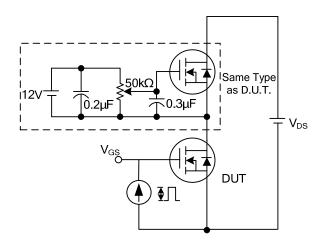
■ TEST CIRCUITS AND WAVEFORMS (Cont.)

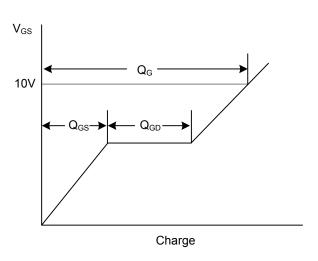




Switching Test Circuit

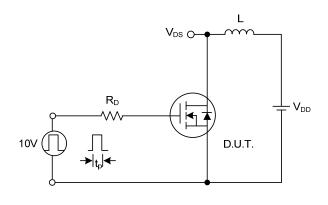
Switching Waveforms

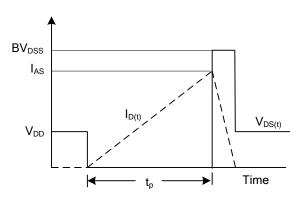




Gate Charge Test Circuit

Gate Charge Waveform





Unclamped Inductive Switching Test Circuit

Unclamped Inductive Switching Waveforms

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